EUSSEN, et al. - 10/720,752

Attorney Docket: 081468-0306993

## **AMENDMENTS TO THE ABSTRACT:**

Please replace the existing Abstract with the replacement Abstract attached hereto on a separate sheet.

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## **ABSTRACT**

A lithographic interferometer system includes a beam generating mechanism, mirrors which reflect those beams, and detection devices configured to detect an interference pattern of overlapping reflected beams. The beam generating mechanism includes a beam-splitter, which splits the beams into reference beams and measuring beams, a reference mirror that provides a plane mirror interferometer, and a reflective surface that emits at least one reference beam used in a differential plane mirror interferometer.